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Advances in X-Ray/EUV Optics and Components VII

**Shunji Goto
Christian Morawe
Ali M. Khounsary**
Editors

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Contents

vii *Conference Committee*

SESSION 1 MULTILAYER OPTICS

- 8502 02 **Advanced multilayer Laue lens fabrication at NSLS-II** [8502-1]
R. Conley, N. Bouet, J. Zhou, H. Yan, Y. Chu, K. Lauer, J. Miller, Brookhaven National Lab. (United States); L. Chu, Northport High School (United States); N. Jahedi, Argonne National Lab. (United States)
- 8502 04 **Aperiodic multilayer mirrors for attosecond soft x-ray pulses** [8502-3]
A. Guggenmos, M. Hofstetter, Ludwig-Maximilians-Univ München (Germany) and Max-Planck-Institut für Quantenoptik (Germany); R. Rauhut, B. Nickel, Ludwig-Maximilians-Univ München (Germany); E. Gullikson, Lawrence Berkeley National Lab. (United States); U. Kleineberg, Ludwig-Maximilians-Univ. München (Germany) and Max-Planck-Institut für Quantenoptik (Germany)
- 8502 06 **A soft x-ray beam-splitting multilayer optic for the NASA GEMS Bragg Reflection Polarimeter** [8502-25]
R. Allured, The Univ. of Iowa (United States); M. Fernández-Perea, R. Soufli, J. B. Alameda, Lawrence Livermore National Lab. (United States); A. Maxwell, The Univ. of Iowa (United States); M. J. Pivovarov, Lawrence Livermore National Lab. (United States); E. M. Gullikson, Lawrence Berkeley National Lab. (United States); P. Kaaret, The Univ. of Iowa (United States)

SESSION 2 SIMULATIONS AND CODES

- 8502 08 **Application of wave optical simulations to focusing x-ray multilayers** [8502-7]
M. Osterhoff, European Synchrotron Radiation Facility (France) and Georg-August-Univ. Göttingen (Germany); C. Morawe, European Synchrotron Radiation Facility (France)
- 8502 09 **Coded aperture imaging for fluorescent x-rays** [8502-28]
A. Haboub, A. A. MacDowell, S. Marchesini, D. Y. Parkinson, Lawrence Berkeley National Lab. (United States)

SESSION 3 MIRRORS AND MONOCHROMATORS

- 8502 0A **Diamond double-crystal monochromator at SPring-8** [8502-9]
S. Goto, H. Yamazaki, Y. Shimizu, M. Suzuki, N. Kawamura, M. Mizumaki, Japan Synchrotron Radiation Research Institute (Japan); M. Yabashi, K. Tamasaku, T. Ishikawa, RIKEN (Japan)
- 8502 0B **Parameterizing the deformation of LN₂-cooled silicon monochromator crystals with modified linear power density function** [8502-10]
R. Huang, D. H. Bilderback, Cornell Univ. (United States)

- 8502 0C **On the limitations of liquid nitrogen cooling of high heat load x-ray monochromators** [8502-11]
A. Khounsary, P. Strons, N. Kujala, A. Macrander, Argonne National Lab. (United States)
- 8502 0D **Novel design of a large x-ray optical system for astrophysical application** [8502-12]
L. Pina, R. Hudec, V. Tichy, Czech Technical Univ. in Prague (Czech Republic); A. Inneman, D. Cerna, J. Marsik, V. Marsikova, Rigaku Innovative Technologies Europe (Czech Republic); W. Cash, A. F. Shipley, B. R. Zeiger, T. D. Rogers, Univ. of Colorado at Boulder (United States); R. Melich, Institute of Plasma Physics of the ASCR, v.v.i. (Czech Republic)
- 8502 0E **Minimizing the mirror distortion for subarcsecond imaging in the Hi-C EUV telescope** [8502-13]
W. A. Podgorski, D. Caldwell, K. McCracken, M. P. Ordway, P. N. Cheimets, K. Korreck, L. Golub, Harvard-Smithsonian Ctr. for Astrophysics (United States); J. Cirtain, K. Kobayashi, NASA Marshall Space Flight Ctr. (United States)
- 8502 0F **Automated finishing of diamond turned dies for hard x-ray and EUV optics replication** [8502-14]
A. T. H. Beaucamp, Chubu Univ. (Japan) and Zeeko Ltd. (United Kingdom); Y. Namba, Chubu Univ. (Japan); R. R. Freeman, Zeeko Ltd. (United Kingdom)

SESSION 4 BEAMLINES AND INSTRUMENTATION

- 8502 0G **Video-based beam position monitoring at CHESS (Invited Paper)** [8502-15]
P. Revesz, A. Pauling, T. Krawczyk, Cornell Univ. (United States); K. J. Kelly, Univ. of Notre Dame (United States)
- 8502 0H **Temporal modulation of synchrotron x-rays using torsional MEMS mirrors** [8502-16]
D. A. Walko, I. W. Jung, D. Lopez, D. Mukhopadhyay, C. P. Schwartz, G. K. Shenoy, J. Wang, Argonne National Lab. (United States)
- 8502 0I **Recent tests of x-ray spectrometers using polycapillary optics** [8502-17]
S. Heald, Argonne National Lab. (United States); G. T. Seidler, D. Mortensen, B. Mattern, Univ. of Washington (United States); J. A. Bradley, Lawrence Livermore National Lab. (United States); N. Hess, M. Bowden, Pacific Northwest National Lab. (United States)
- 8502 0J **Enhanced x-ray angular dispersion and x-ray spectrographs with resolving power beyond 10^8** [8502-18]
Y. Shvyd'ko, Argonne National Lab. (United States)
- 8502 0K **3D x-ray fluorescence microscopy with 1.7 μm resolution using lithographically fabricated micro-channel arrays** [8502-19]
A. R. Woll, D. Agyeman-Budu, D. H. Bilderback, D. Dale, A. Y. Kazimirov, Cornell Univ. (United States); M. Pfeifer, Advanced Design Consulting (United States); T. Plautz, T. Szebenyi, G. Untracht, Cornell Univ. (United States)
- 8502 0L **Addressable flat-panel x-ray sources for medical, security, and industrial applications** [8502-20]
G. Travish, Univ. of California, Los Angeles (United States) and Radius Diagnostics Research, Inc. (United States); F. J. Rangel, M. A. Evans, B. Hollister, K. Schmiedehausen, Radius Diagnostics Research, Inc. (United States)

POSTER SESSION

- 8502 0M **Achieving optimal flatness and surface roughness properties for novel x-ray optic structures formed by dicing saws** [8502-21]
M. Wiecek, R. Khachatryan, Y. Shvyd'ko, Argonne National Lab. (United States);
R. H. Smith, Advanced Dicing Technologies Ltd. (United States); K. Iwasaki, Disco Hi-Tec America, Inc. (United States); S. Miller, J. Qian, X. Huang, L. Assoufid, Argonne National Lab. (United States)
- 8502 0O **Thermo-mechanical properties of silicon, germanium, diamond, beryllium and silicon carbide for high heat load x-ray optics applications** [8502-23]
A. Hedayat, Univ. of Illinois at Chicago (United States); A. Khounsary, Argonne National Lab. (United States); F. Mashayek, Univ. of Illinois at Chicago (United States)
- 8502 0P **Upgrade of the beamline 10.0.1 at the advanced light source** [8502-26]
Z. Ali, Lawrence Berkeley National Lab. (United States) and Optics Labs. (Pakistan);
Y.-D. Chuang, D. Kilcoyne, A. Aguilar, S.-K. Mo, Z. Hussain, Lawrence Berkeley National Lab. (United States)

Author Index

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Session Chairs

- 1 Multilayer Optics
Christian Morawe, European Synchrotron Radiation Facility (France)
Regina Soufli, Lawrence Livermore National Laboratory (United States)
- 2 Simulations and Codes
Shunji Goto, Japan Synchrotron Radiation Research Institute (Japan)
Carolyn A. MacDonald, University at Albany (United States)
- 3 Mirrors and Monochromators
Kazuto Yamauchi, Osaka University (Japan)
Ladislav Pina, Czech Technical University in Prague (Czech Republic)
- 4 Beamlines and Instrumentation
Ali Khounsary, Argonne National Laboratory (United States)
Stanislav Stoupin, Argonne National Laboratory (United States)